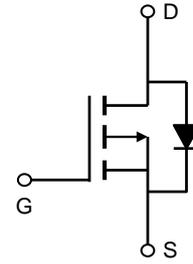


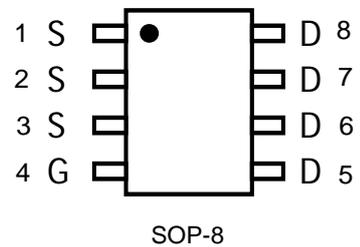
General Description

The AO4419 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for load switch and battery protection applications.



Product Summary

| | |
|-------------------------------------|----------------|
| V_{DS} | -30V |
| I_D (at $V_{GS}=-10V$) | -9.7A |
| $R_{DS(ON)}$ (at $V_{GS}=-10V$) | < 20m Ω |
| $R_{DS(ON)}$ (at $V_{GS} = -4.5V$) | < 35m Ω |



| Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted | | | |
|--|------------------|------------------------|------------------|
| Parameter | Symbol | Maximum | Units |
| Drain-Source Voltage | V_{DS} | -30 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current | I_D | $T_A=25^\circ\text{C}$ | -9.7 |
| | | $T_A=70^\circ\text{C}$ | -7.8 |
| Pulsed Drain Current ^C | I_{DM} | -70 | A |
| Avalanche Current ^C | I_{AS}, I_{AR} | -27 | A |
| Avalanche energy $L=0.1\text{mH}$ ^C | E_{AS}, E_{AR} | 36 | mJ |
| Power Dissipation ^B | P_D | $T_A=25^\circ\text{C}$ | 3.1 |
| | | $T_A=70^\circ\text{C}$ | 2 |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | $^\circ\text{C}$ |

| Thermal Characteristics | | | | | |
|--|---------------------|-----------------|-----|-----|--------------------|
| Parameter | | Symbol | Typ | Max | Units |
| Maximum Junction-to-Ambient ^A | $t \leq 10\text{s}$ | $R_{\theta JA}$ | 31 | 40 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient ^{A D} | Steady-State | | 59 | 75 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Lead | Steady-State | $R_{\theta JL}$ | 16 | 24 | $^\circ\text{C/W}$ |

Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|------|-------|----------|-------|
| STATIC PARAMETERS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D =-250μA, V _{GS} =0V | -30 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =-30V, V _{GS} =0V T _J =55°C | | | -1 -5 | μA |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} = ±20V | | | ±100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} I _D =-250μA | -1.5 | -2.0 | -2.5 | V |
| I _{D(ON)} | On state drain current | V _{GS} =-10V, V _{DS} =-5V | -70 | | | A |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} =-10V, I _D =-9.7A | | 16.5 | 20 | mΩ |
| | | V _{GS} =-4.5V, I _D =-7A | | 26 | 35 | mΩ |
| g _{FS} | Forward Transconductance | V _{DS} =-5V, I _D =-9.7A | | 27 | | S |
| V _{SD} | Diode Forward Voltage | I _S =-1A, V _{GS} =0V | | -0.75 | -1 | V |
| I _S | Maximum Body-Diode Continuous Current | | | | -4 | A |
| I _{SM} | Pulsed Body-Diode Current | | | | -70 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =-15V, f=1MHz | | 1040 | | pF |
| C _{oss} | Output Capacitance | | | 180 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 125 | | pF |
| R _g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | 2 | 4 | 6 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q _{g(10V)} | Total Gate Charge | V _{GS} =-10V, V _{DS} =-15V, I _D =-9.7A | | 19 | | nC |
| Q _{g(4.5V)} | Total Gate Charge | | | 9.6 | | nC |
| Q _{gs} | Gate Source Charge | | | 3.6 | | nC |
| Q _{gd} | Gate Drain Charge | | | 4.6 | | nC |
| t _{D(on)} | Turn-On DelayTime | V _{GS} =-10V, V _{DS} =-15V, R _L =1.5Ω, R _{GEN} =3Ω | | 10 | | ns |
| t _r | Turn-On Rise Time | | | 5.5 | | ns |
| t _{D(off)} | Turn-Off DelayTime | | | 26 | | ns |
| t _f | Turn-Off Fall Time | | | 9 | | ns |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =-9.7A, dI/dt=500A/μs | | 11.5 | | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =-9.7A, dI/dt=500A/μs | | 25 | | nC |

A. The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on T_{J(MAX)}=150°C, using ≤ 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C. Ratings are based on low frequency and duty cycles to keep initial T_J=25°C.

D. The R_{θJA} is the sum of the thermal impedance from junction to lead R_{θJL} and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T_{J(MAX)}=150°C. The SOA curve provides a single pulse rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

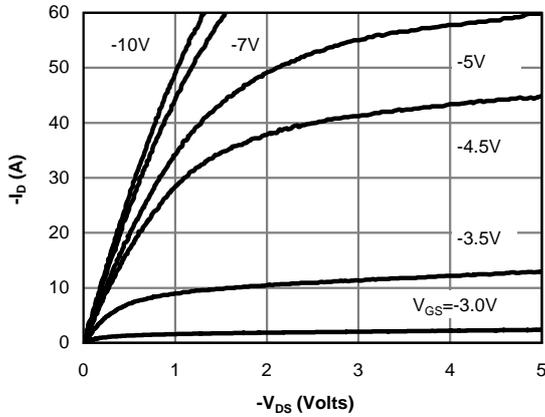


Figure 1: On-Region Characteristics (Note E)

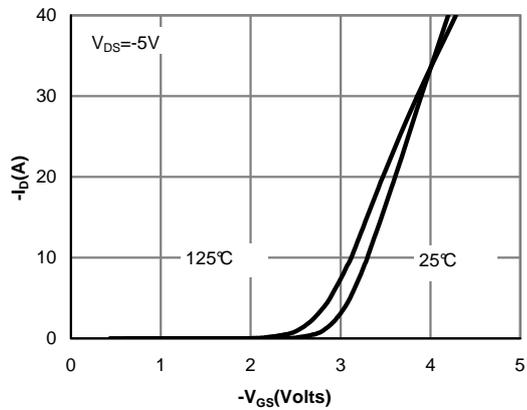


Figure 2: Transfer Characteristics (Note E)

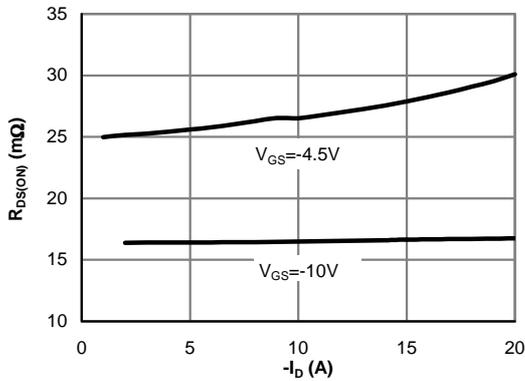


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

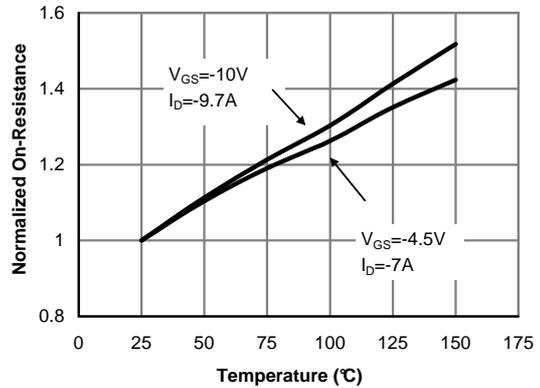


Figure 4: On-Resistance vs. Junction Temperature (Note E)

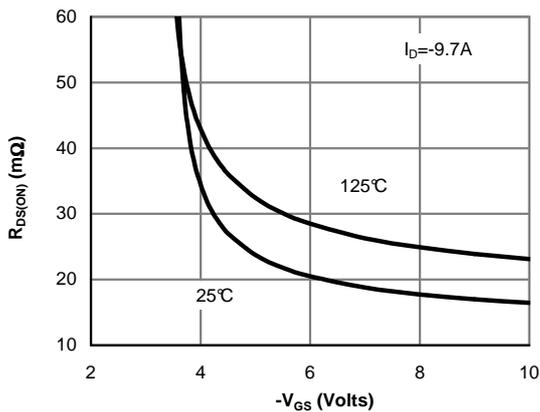


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

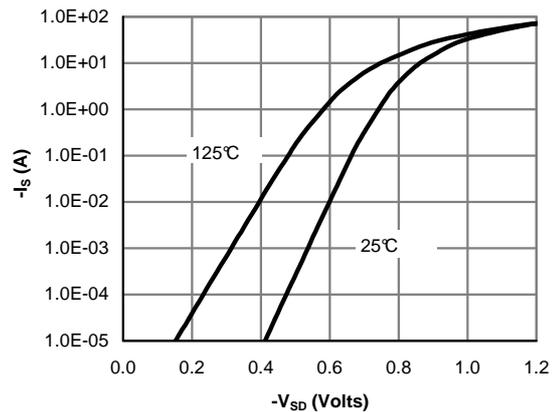


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

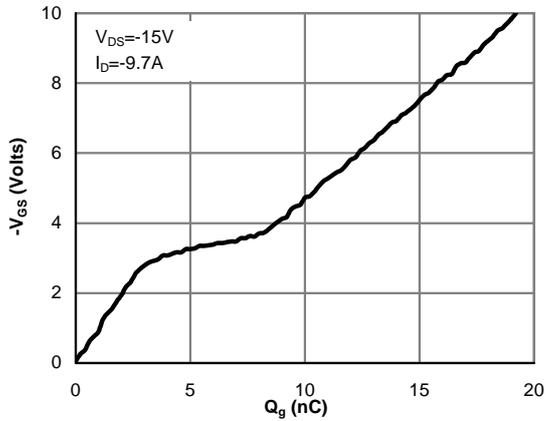


Figure 7: Gate-Charge Characteristics

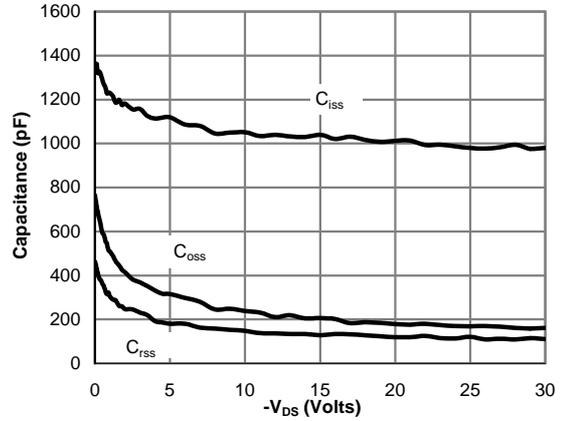


Figure 8: Capacitance Characteristics

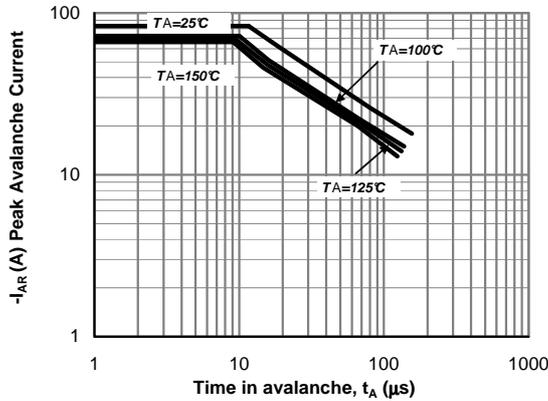


Figure 9: Single Pulse Avalanche capability (Note C)

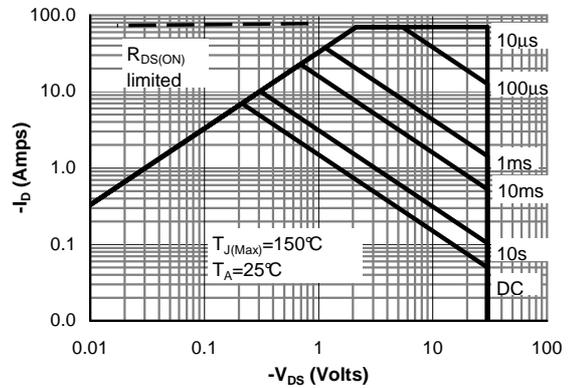


Figure 10: Maximum Forward Biased Safe Operating Area (Note F)



Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

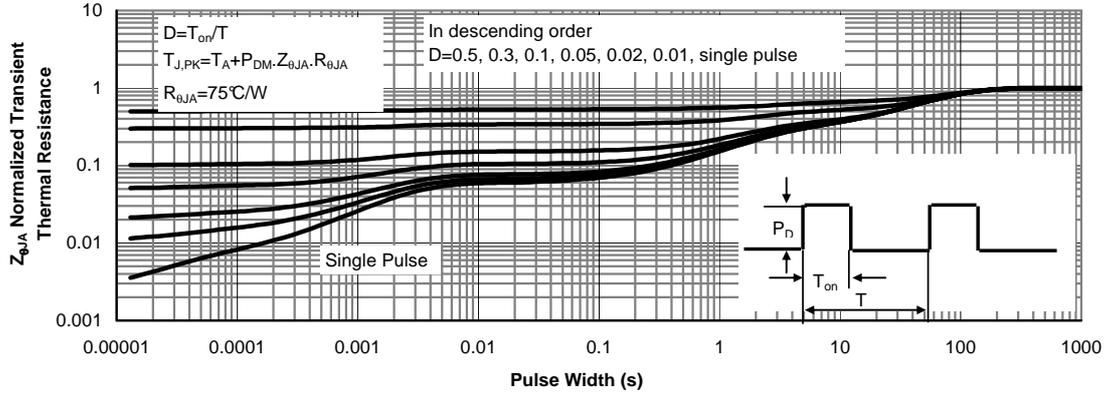
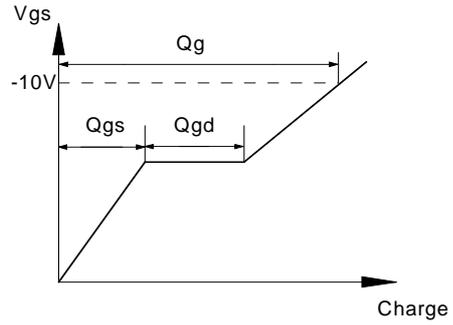
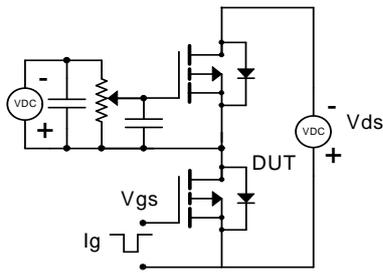


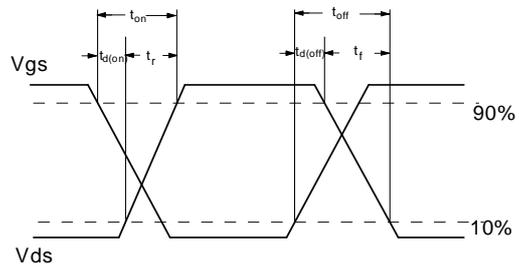
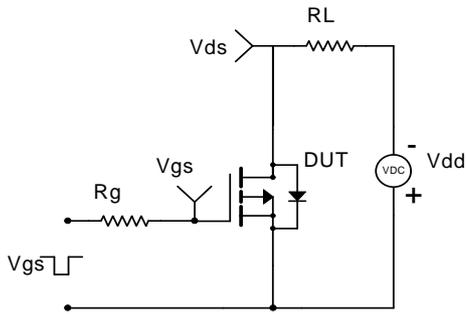
Figure 12: Normalized Maximum Transient Thermal Impedance (Note F)

30V P-Channel MOSFET

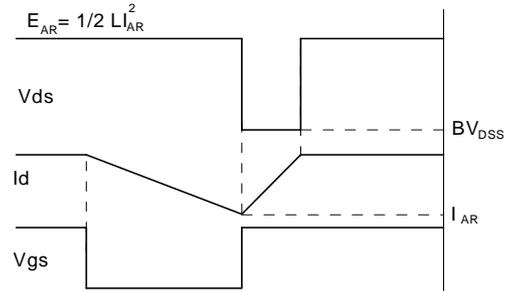
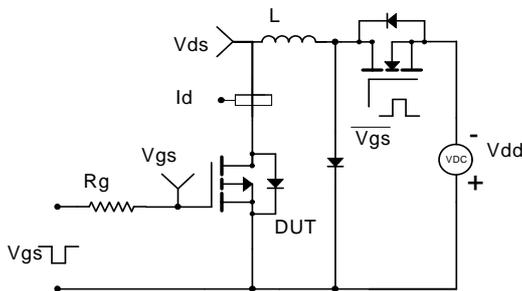
Gate Charge Test Circuit & Waveform



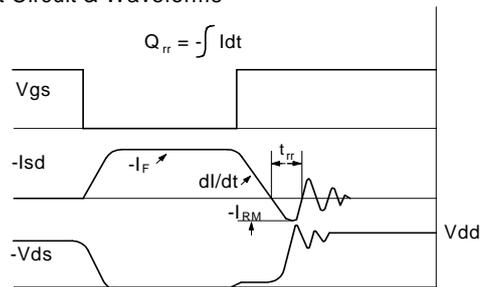
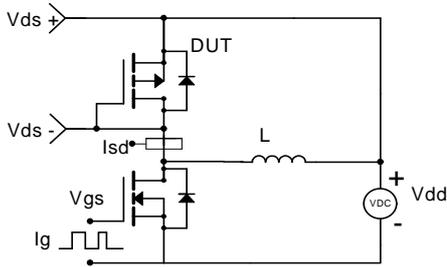
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

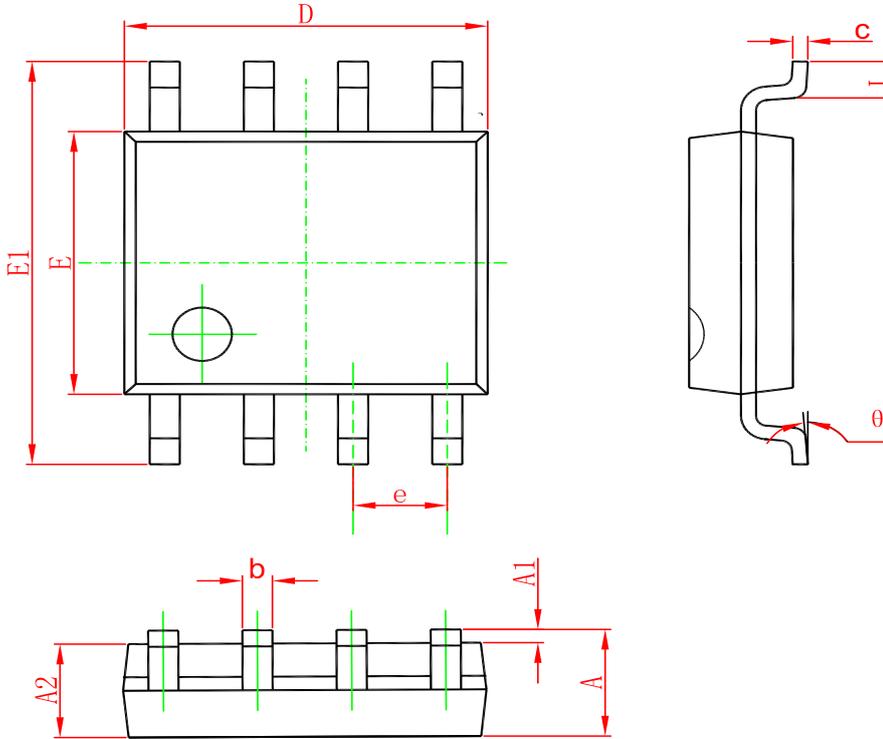


Diode Recovery Test Circuit & Waveforms



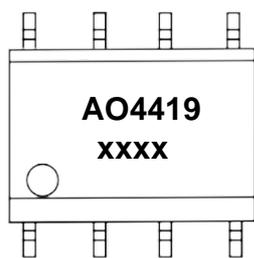
PACKAGE OUTLINE DIMENSIONS

SOP-8



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|-------|----------------------|-------|
| | Min | Max | Min | Max |
| A | 1.350 | 1.750 | 0.053 | 0.069 |
| A1 | 0.100 | 0.250 | 0.004 | 0.010 |
| A2 | 1.350 | 1.550 | 0.053 | 0.061 |
| b | 0.330 | 0.510 | 0.013 | 0.020 |
| c | 0.170 | 0.250 | 0.006 | 0.010 |
| D | 4.700 | 5.100 | 0.185 | 0.200 |
| E | 3.800 | 4.000 | 0.150 | 0.157 |
| E1 | 5.800 | 6.200 | 0.228 | 0.244 |
| e | 1.270(BSC) | | 0.050(BSC) | |
| L | 0.400 | 1.270 | 0.016 | 0.050 |
| θ | 0° | 8° | 0° | 8° |

Marking



("xxxx"代表年份周期)

Ordering information

| Order code | Package | Baseqty | Deliverymode |
|------------|---------|---------|---------------|
| AO4419 | SOP-8 | 3000 | Tape and reel |